	Application No.	Applicant(s)	
A1-4* PAII 1****	10/780,610	MURAYA ET AL.	
Notice of Allowability	Examiner	Art Unit	
	Jimmy Nguyen	2829	
The MAILING DATE of this communication appears on the cover sheet with the correspondence address All claims being allowable, PROSECUTION ON THE MERITS IS (OR REMAINS) CLOSED in this application. If not included herewith (or previously mailed), a Notice of Allowance (PTOL-85) or other appropriate communication will be mailed in due course. THIS NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RIGHTS. This application is subject to withdrawal from issue at the initiative of the Office or upon petition by the applicant. See 37 CFR 1.313 and MPEP 1308.			
1. This communication is responsive to 2/19/04.			
2. The allowed claim(s) is/are 1 - 26.			
3. The drawings filed on are accepted by the Examiner.			
 4. Acknowledgment is made of a claim for foreign priority unas All b) Some* c) None of the: 1. Certified copies of the priority documents have 2. Certified copies of the priority documents have 3. Copies of the certified copies of the priority do International Bureau (PCT Rule 17.2(a)). * Certified copies not received: Applicant has THREE MONTHS FROM THE "MAILING DATE" noted below. Failure to timely comply will result in ABANDONN THIS THREE-MONTH PERIOD IS NOT EXTENDABLE. 5. A SUBSTITUTE OATH OR DECLARATION must be subm INFORMAL PATENT APPLICATION (PTO-152) which give 6. CORRECTED DRAWINGS (as "replacement sheets") must (a) including changes required by the Notice of Draftspers 1) hereto or 2) to Paper No./Mail Date (b) including changes required by the attached Examiner' 	e been received. e been received in Application No cuments have been received in this of this communication to file a reply MENT of this application. hitted. Note the attached EXAMINER es reason(s) why the oath or declara st be submitted. son's Patent Drawing Review (PTO-	national stage application from the complying with the requirem S AMENDMENT or NOTICE tion is deficient.	ents
Paper No./Mail Date <u>0804</u> . Identifying indicia such as the application number (see 37 CFR 1.84(c)) should be written on the drawings in the front (not the back) of each sheet. Replacement sheet(s) should be labeled as such in the header according to 37 CFR 1.121(d).			
 DEPOSIT OF and/or INFORMATION about the deposit of BIOLOGICAL MATERIAL must be submitted. Note the attached Examiner's comment regarding REQUIREMENT FOR THE DEPOSIT OF BIOLOGICAL MATERIAL. 			
 Attachment(s) 1. ☑ Notice of References Cited (PTO-892) 2. ☐ Notice of Draftperson's Patent Drawing Review (PTO-948) 3. ☑ Information Disclosure Statements (PTO-1449 or PTO/SB/C Paper No./Mail Date 0808) 4. ☐ Examiner's Comment Regarding Requirement for Deposit of Biological Material 	6. ☐ Interview Summary Paper No./Mail Dat 08), 7. ☑ Examiner's Amendr	ie	
 Notice of References Cited (PTO-892) Notice of Draftperson's Patent Drawing Review (PTO-948) Information Disclosure Statements (PTO-1449 or PTO/SB/O Paper No./Mail Date 0808 Examiner's Comment Regarding Requirement for Deposit 	6. ☐ Interview Summary Paper No./Mail Dat 08), 7. ☑ Examiner's Amendr	(PTO-413), te nent/Comment	

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DETAILED ACTION

Drawings

1. Figures 15, 16 should be designated by a legend such as --Prior Art-- because only that which is old is illustrated. See MPEP § 608.02(g). Corrected drawings in compliance with 37 CFR 1.121(d) are required in reply to the Office action to avoid abandonment of the application. The replacement sheet(s) should be labeled "Replacement Sheet" in the page header (as per 37 CFR 1.121(d)) so as not to obstruct any portion of the drawing figures. If the changes are not accepted by the examiner, the applicant will be notified and informed of any required corrective action in the next Office action. The objection to the drawings will not be held in abeyance.

Reasons for Allowance

1. The following is an examiner's statement of reasons for allowance:

The prior art that the examiner provides for the applicants do not disclose the combination of an apparatus for measuring a voltage fluctuation a power source system of a functional circuit waveform of operated on a first rated voltage in a semiconductor integrated circuit, comprising:

A grounded system and a power-source-system waveform converting circuit, disposed close to the functional circuit and in the semiconductor integrated circuit and operated on second rated voltage higher than the first rated voltage, converting said voltage fluctuation waveform of the power

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source system into an electrical current waveform;

A grounded system and a power-source-system fluctuation waveform output

terminal for outputting said electric current waveform obtained by said power-source-

system waveform converting circuit outside the semiconductor integrated circuit; and

A grounded system and a power-source-system fluctuation waveform output

wiring, arranged in the semiconductor integrated circuit, for connecting said power-

source-system waveform converting

circuit and said power-source-system fluctuation waveform output terminal.

Any comments considered necessary by applicant must be submitted no later

than the payment of the issue fee and to avoid processing delays, should preferably

accompany the issue fee. Such submissions should be clearly labeled ""Comments on

Statement of Reasons for Allowance."

2. Any inquiry concerning this communication or earlier communications from the

examiner should be directed to Jimmy Nguyen whose telephone number is

(571) 272-1965.

Any inquiry of a general nature or relating to the status of this application or

proceeding should be directed to the Group receptionist whose telephone number is

(703) 305-4900.

JN

Michael Tokar Supervisory Patent Examiner

Minhal J. Tokar

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Technology Center 2800